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 6.3 Chemical Composition, Chemical States, and Thickness of Passive Films on Metals and Alloys  
 6.4 Two-Dimensional Oxide Passive Films on Metals; 6.5 Growth and Nanostructure of Three-Dimensional Ultrathin Oxide Films; 6.6 Corrosion Modeling by DFT; 6.7 Conclusion; Chapter 7: Oxide Films as Catalytic Materials and Models of Real Catalysts; 7.1 Introduction; 7.2 Oxide Thin Films Grown as Supports; 7.3 Systems to Model Real Catalysts; 7.4 Ultrathin-Film Catalysts; 7.5 Synopsis; Acknowledgments; Chapter 8: Oxide Films in Spintronics; 8.1 Introduction; 8.2 Historical Notes  
 8.3 Half-Metallic Manganites: the Case of LSMO  
 8.4 Electric Control of Magnetization in Oxide Heterostructures; 8.5 Conclusions and Perspectives; Acknowledgments; Chapter 9: Oxide Ultrathin Films for Solid Oxide Fuel Cells; 9.1 Overview of Solid Oxide Fuel Cell Technology; 9.2 Preparation of Oxide Ion Conductor Thin Films; 9.3 Nano Size Effects on Oxide Ion Conductor Films; 9.4 Power Generating Property of SOFCs using LaGaO<sub>3</sub> Thin Films; 9.5 Development of -SOFCs; 9.6 Concluding Remarks; Chapter 10: Transparent Conducting and Chromogenic Oxide Films as Solar Energy Materials; 10.1 Introduction  
 10.2 Transparent Infrared Reflectors and Transparent Electrical Conductors

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Sommario/riassunto

A wealth of information in one accessible book. Written by international experts from multidisciplinary fields, this in-depth exploration of oxide ultrathin films covers all aspects of these systems, starting with preparation and characterization, and going on to geometrical and electronic structure, as well as applications in current and future systems and devices. From the Contents: Synthesis and Preparation of Oxide Ultrathin Films  
 Characterization Tools of Oxide Ultrathin Films  
 Ordered Oxide Nanostructures on Metal Surfaces  
 Unusual Properties of

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